

Search Notes

Application/Control No.

10/053,340

Examiner

Than Nguyen

Applicant(s)/Patent under
Reexamination

WARE ET AL.

Art Unit

2187

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST Inventor IEEE	1/31/2008	NTV